

Notice of References Cited

Application/Control No.

09/549,559

Applicant(s)/Patent Under
Reexamination
CEDERVALL ET AL.

Examiner

Edith M Yeh

Art Unit

2634

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,314,147 B1	11-2001	Liang et al.	375/346
	B	US-5,848,105	12-1998	Gardner et al.	375/336
	C	US-5,432,821	07-1995	Polydoros et al.	375/340
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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